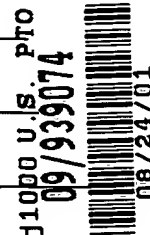


Form PTO 1449 U.S. Dept of Commerce  
Rev 7-80 Patent & Trademark Off.

: Atty. Docket No. : Serial No.  
: SJ0920010018US1 not assigned  
: Applicant(s)  
: A. David Erpelding  
: File Date : Group  
: herewith : not assigned

LIST OF PRIOR ART CITED BY APPLICANT(S)  
(Use several sheets if necessary)



### U.S. PATENT DOCUMENTS

EXAM.:	DOCUMENT			CLASS/	FILING
INTL.:	NUMBER	DATE	NAME	SUBCLASS	DATE
MB	:AA: 6108171	08/22/00	W. Coon et al.	360/244.2	10/15/98
MB	:AB: 5894381	04/13/99	A. M. Allen et al.	360/104	07/14/97
MB	:AC: 5850319	12/15/98	J. H. Tangren	360/104	03/28/97
MB	:AD: 5657187	08/12/97	M. R. Hatch et al.	360/104	12/05/95
MB	:AE: 5065268	11/12/91	T. M. Hagen	360/104	12/22/89
MB	:AF: 4760478	07/26/88	G. S. Pal et al.	360/104	07/08/86
MB	:AG: 6141187	10/31/00	C. Wong et al.	360/244.8	03/18/98
MB	:AH: 6104572	08/15/00	S. P. Williams et al.	360/104	09/25/97
MB	:AI: 6046884	04/04/00	P. Crane	360/104	11/14/97

### FOREIGN DOCUMENTS

: DOC. NO.	: DATE	: COUNTRY	: CLASS/	: TRANSLATION
:	:	:	: SUBCLASS	YES : NO
:BA:				:
:BB:				:
:BC:				:
:BD:				:
:BE:				:
:BF:				:
:BG:				:

### OTHER PRIOR ART (INCLUD. AUTHOR, TITLE, DATE, PERTINENT PG., ETC.)

:CA: IBM Technical Disclosure Bulletin, Feb. 1990 "Automatic Adjustment of In-Line Gram Form Process, pp. 89-90

:CB:

:CC:

:CD:

:CE:

EXAMINER

DATE CONSIDERED

5/28/04

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).